

	Type	L #	Hits	Search Text	Dbs	Time Stamp	Comments	Error Definition	Err ors
8	BRS	L8	3681	((collimator or collima\$4) same(x-ray or x-rays or x-raying or x-rayed or x-ray\$3 near3 beam\$1))	USPAT	2004/01/27 13:54			0
9	BRS	L9	88	8 and(inspec\$4 or detc\$4)same (integrate\$1 or wafer\$1 or "IC"chip\$1 or printed near3 circuits) and (void\$1 or defect\$2)	USPAT	2004/01/27 12:44			0
10	BRS	L10	1	9 and (multiaperture or multi-aperture or multi adj1 aperture)	USPAT	2004/01/27 12:46			0
11	BRS	L11	46	8 and(inspec\$4 or detc\$4)same (integrate\$1 near3 circuit\$1 or wafer\$1 or "IC"chip\$1 or printed near3 circuits) and (void\$1 or defect\$2)	USPAT	2004/01/27 13:55			0
12	BRS	L12	0	11 and (multiaperture or multi-aperture or multi adj1 aperture)	USPAT	2004/01/27 13:56			0
13	BRS	L13	17	11 and aperture\$2	USPAT	2004/01/27 12:47			0
14	BRS	L14	6126	382/141,145,147,149,151;438 /16;378/51-69,145-161,140.c cls.	USPAT	2004/01/27 13:54			0
15	BRS	L15	1040	14 and((collimator or collima\$4) same(x-ray or x-rays or x-raying or x-rayed or x-ray\$3 near3 beam\$1))	USPAT	2004/01/27 13:54			0
16	BRS	L16	7	15 and(inspec\$4 or detc\$4)same (integrate\$1 near3 circuit\$1 or wafer\$1 or "IC"chip\$1 or printed near3 circuits) and (void\$1 or defect\$2)	USPAT	2004/01/27 13:57			0

	Type	L #	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition	Err ors
17	BRS	L18	0	17 and (inspect\$4 or detect\$4) same (integrate\$1 near3 circuit\$1 or wafer\$1 or "IC" chip\$1 or printed near3 circuits) and (void\$1 or defect\$2)	USPAT	2004/01/27 13:57			0
18	BRS	L17	49	15 and (multiaperture or multi-aperture or multi adj1 aperture or plurality near3 apertures)	USPAT	2004/01/27 13:57			0

	Type	L #	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition	Err Org
1	BRS	L1	0	((((inspec\$4 or detect\$4) same (integrate\$1 or wafer\$1 or "IC"chip\$1 or printed near3 circuits)) same (void\$1 or defect\$2)) same ((collimator or collima\$4) near3(x-ray or x-rays or x-raying or x-rayed)))	USPAT	2004/01/27 11:41			0
2	BRS	L2	0	((((inspec\$4 or detect\$4) same (integrate\$1 or wafer\$1 or "IC"chip\$1 or printed near3 circuits)) same (void\$1 or defect\$2)) same ((collimator or collima\$4) near3(x-ray or x-rays or x-raying or x-rayed)))	USPAT	2004/01/27 12:38			0
3	BRS	L3	2126	((collimator or collima\$4) near3(x-ray or x-rays or x-raying or x-rayed))	USPAT	2004/01/27 11:49			0
4	BRS	L4	1	3 same (multiaperture or multi-aperture or multi adj1 aperture)	USPAT	2004/01/27 11:48			0
5	BRS	L5	2	3 and (multiaperture or multi-aperture or multi adj1 aperture)	USPAT	2004/01/27 11:50			0
6	BRS	L6	3681	((collimator or collima\$4) same(x-ray or x-rays or x-raying or x-rayed or x-ray near3 beam))	USPAT	2004/01/27 11:51			0
7	BRS	L7	4	6 and (multiaperture or multi-aperture or multi adj1 aperture)	USPAT	2004/01/27 12:40			0